

<b>Notice of References Cited</b>	Application/Control No. 10/606,045	Applicant(s)/Patent Under Reexamination LYNCH ET AL.	
	Examiner /BINH K. TIEU/	Art Unit 2614	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0202132	10-2004	Heinonen et al.	370/331
*	B	US-2005/0058144	03-2005	Ayyagari et al.	370/401
	C	US-			
	D	US-			
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	F	US-			
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**FOREIGN PATENT DOCUMENTS**

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